

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/664,903	FINK, STEVEN T.	
	<b>Examiner</b> Thuy V. Tran	<b>Art Unit</b> 2821	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner